













SCES626E -MARCH 2005-REVISED JUNE 2017

# SN74AUC1G19 1-of-2 Decoder/Demultiplexer

#### 1 Features

- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- Available in the Texas Instruments NanoFree<sup>™</sup> Package
- Optimized for 1.8-V Operation and Is 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Sub-1-V Operable
- ±8-mA Output Drive at 1.8 V V<sub>CC</sub>
- Maximum t<sub>pd</sub> of 3 ns at 1.8 V
- Low Power Consumption, 10-μA Maximum I<sub>CC</sub>

## 2 Applications

- AV Receiver
- Audio Dock: Portable
- Blu-ray Player and Home Theater
- Embedded PC
- MP3 Player/Recorder (Portable Audio)
- Personal Digital Assistant (PDA)
- Power: Telecom/Server AC/DC Supply: Single Controller: Analog and Digital
- Solid State Drive (SSD): Client and Enterprise
- TV: LCD/Digital and High-Definition (HDTV)
- Tablet: Enterprise
- Video Analytics: Server
- · Wireless Headset, Keyboard, and Mouse

### 3 Description

This 1-of-2 decoder/demultiplexer is operational at 0.8-V to 2.7-V  $V_{CC}$ , but is designed specifically for 1.65-V to 1.95-V  $V_{CC}$  operation.

The SN74AUC1G19 is a 1-of-2 decoder/demultiplexer. This device buffers the data on input A and passes it to the outputs  $Y_0$  (true) and  $Y_1$  (complement) when the enable (E) input signal is low.

NanoFree<sup>™</sup> package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using  $I_{\rm off}$ . The  $I_{\rm off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

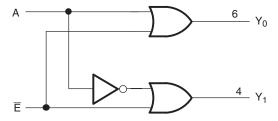
For more information about AUC Little Logic devices, see *Applications of Texas Instruments AUC Sub-1-V Little Logic Devices*, SCEA027.

#### Device Information<sup>(1)</sup>

_		= <del>=</del>
PART NUMBER	PACKAGE	BODY SIZE (NOM)
SN74AUC1G19DBV	SOT-23 (6)	2.90 mm × 1.60 mm
SN74AUC1G19DCK	SC70 (6)	2.00 mm x 1.25 mm
SN74AUC1G19DRL	SOT-5X3 (6)	1.60 mm × 1.20 mm
SN74AUC1G19YZP	DSBGA (6)	1.50 mm × 0.90 mm

 For all available packages, see the orderable addendum at the end of the data sheet.

#### Logic Diagram (Positive Logic)





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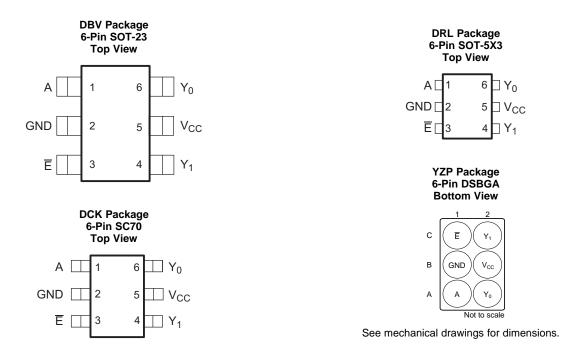
# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	hanges from Revision D (April 2007) to Revision E	Page
•	Deleted DRY package throughout data sheet	1
•	Added Application section, Device Information table, Pin Configuration and Functions section, ESD Ratings table, Thermal Information table, Feature Description section, Device Functional Modes, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	1
•	Deleted Ordering Information table, see Mechanical, Packaging, and Orderable Information at the end of the data sheet	1



### 5 Pin Configuration and Functions



#### **Pin Functions**

	PIN						
NAME	DBV, DCK, DRL	YZP	I/O	DESCRIPTION			
Α	1	A1	I	A Input			
Ē	3	C1	I	Active Low Enable			
GND	2	B1	_	Ground			
V <sub>CC</sub>	5	B2	_	Positive Supply			
Y <sub>0</sub>	6	A2	0	Y <sub>0</sub> True Output			
Y <sub>1</sub>	4	C2	0	Y <sub>1</sub> Complemented Output			

# 6 Specifications

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage		-0.5	3.6	V
$V_{I}$	Input voltage (2)		-0.5	3.6	V
Vo	Voltage range applied to any output in the	high-impedance or power-off state <sup>(2)</sup>	-0.5	3.6	V
Vo	Voltage range applied to any output in the	high or low state <sup>(2) (3)</sup>	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		<b>-</b> 50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		<b>-</b> 50	mA
Io	Continuous output current			±20	mA
	Continuous current through $V_{CC}$ or GND			±100	mA
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

3) The value of V<sub>CC</sub> is provided in the recommended operating conditions table.



### 6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	2000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	1000	V
		Machine Model (A115-A)	200	

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

See(1)

			MIN	MAX	UNIT	
$V_{CC}$	Supply voltage		0.8	2.7	V	
		V <sub>CC</sub> = 0.8 V	V <sub>CC</sub>	3.6		
$V_{IH}$	High-level control input voltage	$V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$	0.65 × V <sub>CC</sub>	3.6	V	
		$V_{CC}$ = 2.3 V to 2.7 V	1.7	3.6		
		V <sub>CC</sub> = 0.8 V		0		
$V_{IL}$	Low-level control input voltage	$V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$	0	$0.35 \times V_{CC}$	V	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	0	0.7		
Vo	Output voltage	·	0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 0.8 V		-0.7		
	High-level control output current	V <sub>CC</sub> = 1.1 V		-3		
I <sub>OH</sub>		V <sub>CC</sub> = 1.4 V		<b>-</b> 5	mA	
		V <sub>CC</sub> = 1.65 V		-8		
		V <sub>CC</sub> = 2.3 V		-9		
		V <sub>CC</sub> = 0.8 V		0.7		
		V <sub>CC</sub> = 1.1 V		3		
$I_{OL}$	Low-level control output current	V <sub>CC</sub> = 1.4 V		5	mA	
		V <sub>CC</sub> = 1.65 V		8		
		V <sub>CC</sub> = 2.3 V		9		
A4/A.	lands translities view on fall nate	V <sub>CC</sub> = 0.8 V to 1.95 V		20	A /	
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		15	ns/V	
T <sub>A</sub>	Operating free-air temperature	·	-40	85	°C	

All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. See *Implications of Slow or Floating CMOS Inputs*, SCBA004.

### 6.4 Thermal Information

			SN74	AUC1G19		
	THERMAL METRIC <sup>(1)</sup>	DBV (SOT-23)	DCK (SC70)	DRL (SOT-5X3)	YZP (DSBGA)	UNIT
		6 PINS	6 PINS	6 PINS	6 PINS	
$R_{\theta JA}$ Junction-to-ambient thermal resistance		206	252	142	132	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN TYP <sup>(1)</sup>	MAX	UNIT
	$I_{OH} = -100 \mu A$	0.8 V to 2.7 V	V <sub>CC</sub> - 0.1		
	$I_{OH} = -0.7 \text{ mA}$	0.8 V	0.55		
V	$I_{OH} = -3 \text{ mA}$	1.1 V	0.8		V
$V_{OH}$	I <sub>OH</sub> = -5 mA	1.4 V	1		V
1	$I_{OH} = -8 \text{ mA}$	1.65 V	1.2		
	$I_{OH} = -9 \text{ mA}$	2.3 V	1.8		
	$I_{OL} = 100 \mu A$	0.8 V to 2.7 V		0.2	
	I <sub>OL</sub> = 0.7 mA	0.8 V	0.25		
	I <sub>OL</sub> = 3 mA	1.1 V		0.3	V
$V_{OL}$	$I_{OL} = 5 \text{ mA}$	1.4 V		0.4	V
	$I_{OL} = 8 \text{ mA}$	1.65 V		0.45	
	$I_{OL} = 9 \text{ mA}$	2.3 V		0.6	
I <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	0 to 2.7 V		±5	μΑ
I <sub>off</sub>	$V_I$ or $V_O = 2.7 V$	0		±10	μΑ
I <sub>cc</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	0.8 V to 2.7 V		10	μΑ
Cı	$V_I = V_{CC}$ or GND	2.5 V	3		pF

<sup>(1)</sup> All typical values are at  $V_{CC}$  = 3.3 V (unless otherwise noted),  $T_A$  = 25°C.

# 6.6 Switching Characteristics: $C_L = 15 pF$

over recommended operating free-air temperature range,  $C_L = 15 \text{ pF}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> = ± 0.1		V <sub>CC</sub> = ± 0.1		V <sub>CC</sub> = ± 0.1		V <sub>CC</sub> = 1 ± 0.2		UNIT	
7.0.0.0	(INPUT)	(001701)	TYP	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		ı
t <sub>pd</sub>	A or $\overline{\overline{E}}$	Υ	7.5	0.5	4.6	0.4	3.0	0.3	2.4	0.2	1.7	ns	

# 6.7 Switching Characteristics: C<sub>L</sub> = 30 pF

over recommended operating free-air temperature range, C<sub>L</sub> = 30 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		UNIT
	(1141 01)	(6611 61)	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	A or E	Y <sub>0</sub> or Y <sub>1</sub>	0.5	2.8	0.4	2.0	ns

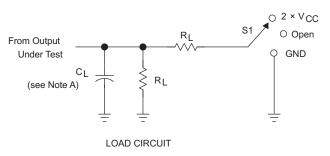
## 6.8 Operating Characteristics

 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> = 1.2 V	V <sub>CC</sub> = 1.5 V	V <sub>CC</sub> =1.8 V	V <sub>CC</sub> = 2.5 V	UNIT
		CONDITIONS	TYP	TYP	TYP	TYP	TYP	
C <sub>pd</sub>	Power dissipation capacitance	f = 10 MHz	13	13	13	13	14	pF

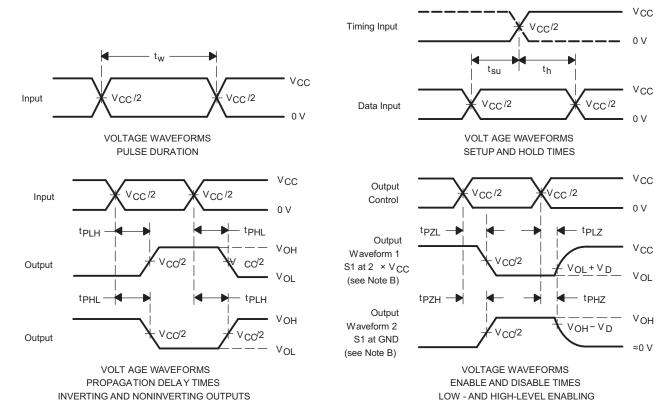


### 7 Parameter Measurement Information



TEST	S1
tPLH/tPHL	Open
tpLZ/tpZL	2 × V <sub>CC</sub>
tPHZ/tPZH	GND

Vcc	CL	RL	٧D
0.8 V	15 pF	2 k Ω	0.1 V
1.2 V ± 0.1 V	15 pF	2 k Ω	0.1 V
1.5 V ± 0.1 V	15 pF	2 k Ω	0.1 V
1.8 V ± 0.15 V	15 pF	2 k Ω	0.15 V
2.5 V ± 0.2 V	15 pF	2 k Ω	0.15 V
1.8 V ± 0.15 V	30 pF	1 k Ω	0.15 V
2.5 V ± 0.2 V	30 pF	500 Ω	0.15 V



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.

  Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHZ,  $Z_o = 50~\Omega$ , slew rate  $\leq$  1 V/ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t PLZ and t PHZ are the same as tdis-
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G. t PLH and t PHL are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

Submit Documentation Feedback

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# 8 Detailed Description

# 8.1 Functional Block Diagram

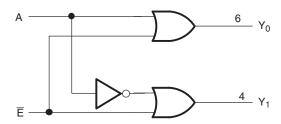


Figure 2. Logic Diagram (Positive Logic)

### 8.2 Device Functional Modes

Table 1 lists the functional mode of the SN74AUC1G19.

**Table 1. Function Table** 

INP	UTS	OUT	PUTS
Ē	Α	Y <sub>0</sub>	Y <sub>1</sub>
L	L	L	Н
L	Н	Н	L
н	X	Н	Н



### 9 Device and Documentation Support

#### 9.1 Documentation Support

#### 9.1.1 Related Documentation

For related documentation see the following:

- Applications of Texas Instruments AUC Sub-1-V Little Logic Devices, SCEA027
- Implications of Slow or Floating CMOS Inputs, SCBA004

### 9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 9.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 9.4 Trademarks

NanoFree, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 9.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





30-Nov-2018

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74AUC1G19DBVR	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	U19R	Samples
SN74AUC1G19DCKR	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	U5R	Samples
SN74AUC1G19DCKT	ACTIVE	SC70	DCK	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	U5R	Samples
SN74AUC1G19DRLR	ACTIVE	SOT-5X3	DRL	6	4000	Green (RoHS & no Sb/Br)	CU NIPDAU   CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	(U57, U5R)	Samples
SN74AUC1G19YZPR	ACTIVE	DSBGA	YZP	6	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	U5N	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



## **PACKAGE OPTION ADDENDUM**

30-Nov-2018

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AUC1G19DBVR	SOT-23	DBV	6	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
SN74AUC1G19DCKR	SC70	DCK	6	3000	180.0	8.4	2.41	2.41	1.2	4.0	8.0	Q3
SN74AUC1G19DCKT	SC70	DCK	6	250	180.0	8.4	2.41	2.41	1.2	4.0	8.0	Q3
SN74AUC1G19DRLR	SOT-5X3	DRL	6	4000	180.0	9.5	1.78	1.78	0.69	4.0	8.0	Q3
SN74AUC1G19DRLR	SOT-5X3	DRL	6	4000	180.0	8.4	1.98	1.78	0.69	4.0	8.0	Q3
SN74AUC1G19YZPR	DSBGA	YZP	6	3000	178.0	9.2	1.02	1.52	0.63	4.0	8.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AUC1G19DBVR	SOT-23	DBV	6	3000	202.0	201.0	28.0
SN74AUC1G19DCKR	SC70	DCK	6	3000	202.0	201.0	28.0
SN74AUC1G19DCKT	SC70	DCK	6	250	202.0	201.0	28.0
SN74AUC1G19DRLR	SOT-5X3	DRL	6	4000	184.0	184.0	19.0
SN74AUC1G19DRLR	SOT-5X3	DRL	6	4000	202.0	201.0	28.0
SN74AUC1G19YZPR	DSBGA	YZP	6	3000	220.0	220.0	35.0



SMALL OUTLINE TRANSISTOR



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation. 5. Refernce JEDEC MO-178.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# DCK (R-PDSO-G6)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AB.



# DCK (R-PDSO-G6)

# PLASTIC SMALL OUTLINE



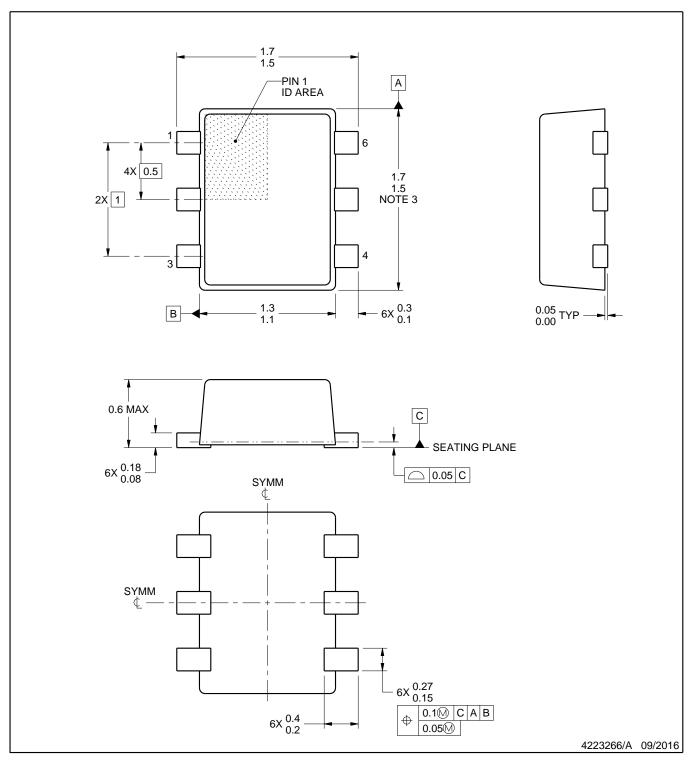
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.





PLASTIC SMALL OUTLINE

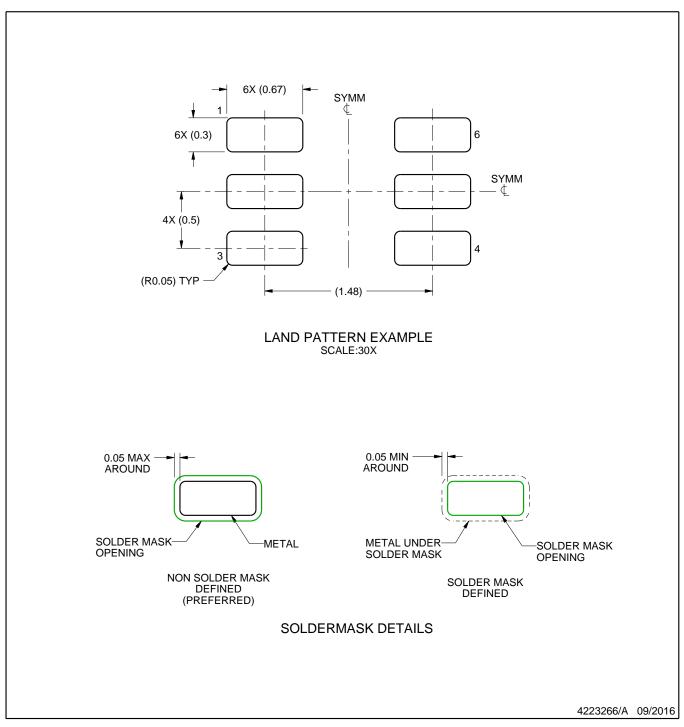


#### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
   This drawing is subject to change without notice.
   This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.



PLASTIC SMALL OUTLINE

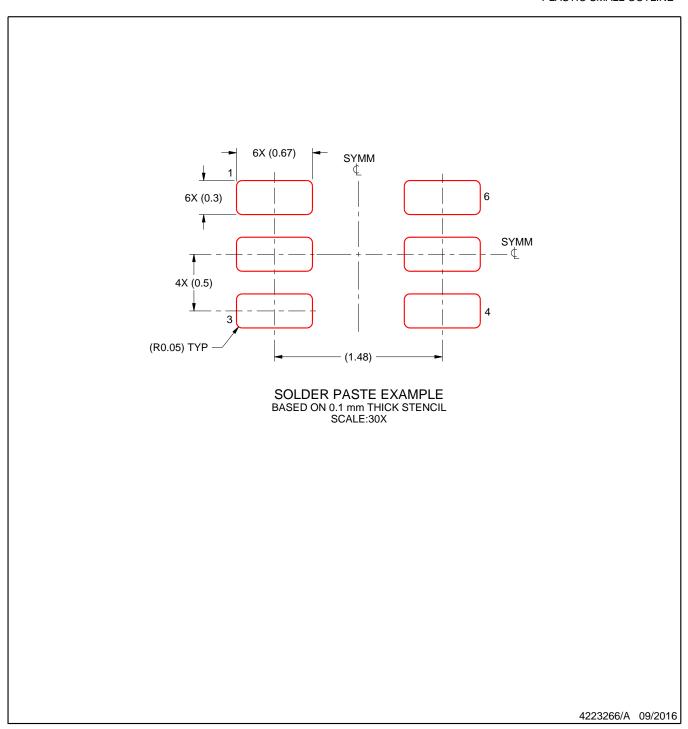


NOTES: (continued)

- 4. Publication IPC-7351 may have alternate designs.
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC SMALL OUTLINE



NOTES: (continued)

- 6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 7. Board assembly site may have different recommendations for stencil design.





DIE SIZE BALL GRID ARRAY



#### NOTES:

NanoFree Is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.
- 3. NanoFree<sup>™</sup> package configuration.



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SBVA017 (www.ti.com/lit/sbva017).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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